

Notice of References Cited	Application/Control No. 10/808,218	Applicant(s)/Patent Under Reexamination UEDA ET AL.	
	Examiner Wen-Ying P. Chen	Art Unit 2871	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2002/0030780	03-2002	NISHIDA et al.	349/141
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	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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